

Features

- 5630 IR VCSEL
- ROHS and REACH Compliant
- ESD(HBM) 8KV

Applications

- Industrial facility applications
- Consumer Mobile
- Automotive Interior & Exterior
- 3D Sensing(TOF, Structure Light)
- Bio recognition



Description

The INV-P53CTRHIR is a low-power IR VCSEL. It is a SMD type package which can be used in various applications.

Recommended Solder Pattern

(Suggest Stencil t=0.12 mm)

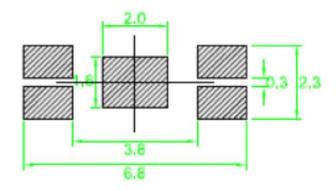


Figure 1. INV-P53CTRHIR Solder Pattern

Package Dimensions in mm

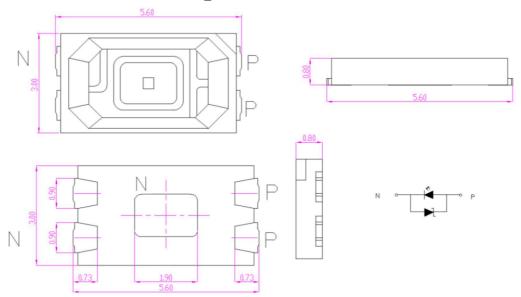


Figure 2. INV-P53CTRHIR Package Dimensions

*Note

All dimensions are in millimeters.

Tolerance is ± 0.1 mm unless other specified.



Absolute Maximum Rating at 25°C (Note 1)

Product	I _{FP} (mA) max	Pd(W) max	V _R (V) Typ.	T _j (°C) Typ.	T _{ST} (°C)	Rth (°C/W)	Soldering Temp. T _{sol} (°C)	ESD HBM (V)
INV-P53CTRHIR	240	0.56	-5	110°C	-40°C~+120°C	60	260 °C	8000

Notes

- 1. For other ambient, limited setting of current will depend on de-rating curves.
- 2. D=0.01s duty 1/10.
- 3. When drive on maximum current , Tj must be kept below 110 $^\circ\!\mathbb{C}$
- 4. Viewing angle(2 θ 1/2) \pm 10°

Electrical Characteristics $T_A = 25$ ^o (Note 1)

Product	V _F (V)@200mA		Radiometric Power (mW) @200mA		Peak Wavelength (nm)		I _R (μ A)	View Angle
Troduct	min	max	min	max	min	max	max	2 <i>θ</i> 1/2
INV-P53CTRHIR	1.8	3.0	90	150	930	950	3	30

*Notes

- 1. Performance guaranteed only under conditions listed in above tables.
- 2. Viewing angle $(2\theta 1/2) \pm 10^{\circ}$

ESD Precaution

ATTENTION: Electrostatic Discharge (ESD) protection



The symbol above denotes that ESD precaution is needed. ESD protection for GaP and AlGaAs based chips is necessary even though they are relatively safe in the presence of low static-electric discharge. Parts built with AlInGaP, GaN, or/and InGaN based chips are STATIC SENSITIVE devices. ESD precaution must be taken during design and assembly.

If manual work or processing is needed, please ensure the device is adequately protected from ESD during the process.

Please be advised that normal static precautions should be taken in the handling and assembly of this device to prevent damage or degradation which may be induced by electrostatic discharge (ESD).



Binning Definition (Binning@200mA)

Power Bin

Bin Code	Min.	Max.	Unit
W94	90	150	mW

Wavelength Bin

Bin Code	Min.	Max.	Unit
W94	930	950	nm

Voltage Bin

Bin Code	Min.	Max.	Unit
V1	1.8	2.2	
V2	2.2	2.6	V
V3	2.6	3.0	

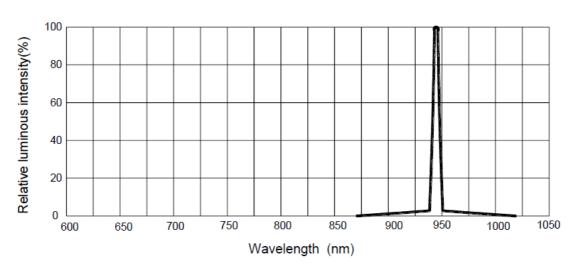
*Notes:

- 1. Radiometric Power (Po) ±10%.
- 2. Wavelength (Wp) ±2.0nm
- 3. Forward voltage (V_F) ±0.12V

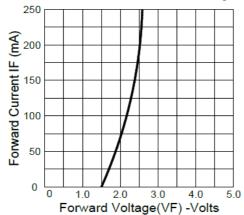


Electronic-Optical Characteristics

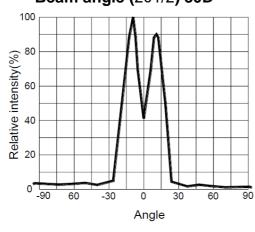
Spectrum Distribution



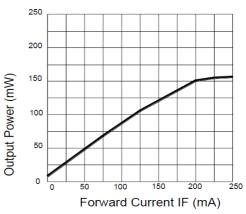
Forward Current VS. Forward Voltage



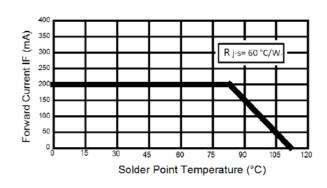
Beam angle (2θ1/2) 30D



Luminous Intensity VS. Forward Current



Thermal Design for De-rating



*Notes:

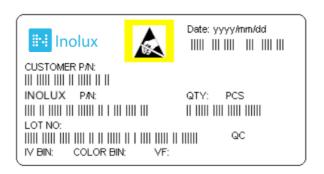
Viewing angle (2θ1/2) ± 10°



Ordering Information

Orderable	Peak	Radiometric F @200	` ,	Forward V @20	Viewing	
Part Number	Wavelength (nm)	Min	Max	Min	Max	Angle
INV-P53CTRHIR	930-950	90	150	1.8	3.0	30°

Label Specifications



Inolux P/N:

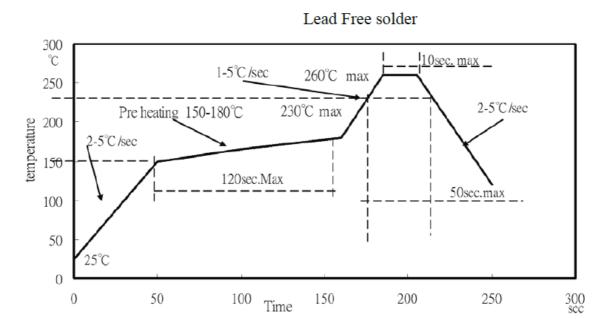
INV	-	Р	5	3	С	T	R		HIR	-	Х	х	х х	
		Material	Pack	kage	Variation	Orientation	Current	Lens	Color			ıston tamp	nized o-off	
Inolux VCSEL		P = PLCC Type	53C =	÷ 5.6 x 3.	0, 120 Deg.	T = Top Mount	R = 200mA	(Blank) = Clear	HIR = 940nm					

Lot No.:

Z	2	0	1	7	01	24	001
Internal		Voor (2017	, 2018,)	Month	Data	Serial	
Tracker		fear (2017	, 2016,)		IVIOIILII	Date	Serial



Reflow Soldering



Soldering Iron

Basic Spec is \leq 4 sec. when 260°C (+10°C \rightarrow -1 second). Power dissipation of Iron should be less than 15W. Surface temperature should be under 230°C

Rework

Rework should be completed within 4 second under 245°C

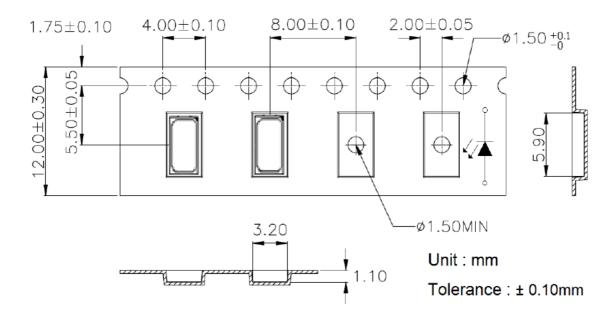
Notes

- 1. Do not stress the silicone resin while it is exposed to high temperature.
- 2. The number of reflow process should not exceed 3 times.

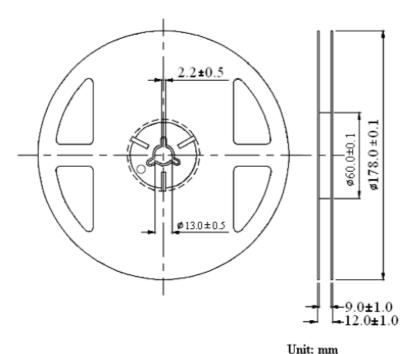


Packing

Carrier Tape Dimensions: Loaded quantity 3000pcs per reel.



Reel Dimensions:



Tolerance: ± 0.25mm



Test Items and Results of Reliability

Test Item	Test Conditions	Duration/ Cycle	Number of Damage	Reference
Thermal Shock	-40°C 30min ↑↓5min 125°C 30min	100 cycles	0/22	AECQ101
High Temperature Storage	Ta=100°C	1000 hrs	0/22	EIAJ ED-4701 200 201
Humidity Heat Storage	Ta=85°ℂ RH=85%	1000 hrs	0/22	EIAJ ED-4701 100 103
Low Temperature Storage	Ta=-40°C	1000 hrs	0/22	EIAJ ED-4701 200 202
Life Test	Ta=25°C If=200mA	1000 hrs	0/22	Tested with Inolux standard
High Humidity Heat Life Test	85°C RH=85% If=200mA	1000 hrs	0/22	Tested with Inolux standard
High Temperature Life Test	Ta=85°C	1000 hrs	0/22	Tested with Inolux standard
ESD(HBM)	2KV at 1.5kΩ;100pf	3 Times	0/22	MIL-STD-883

Criteria for Judging the Damage								
lk a	Cala al	Canaditian	Criteria for Judgment					
ltem	Symbol	Condition	Min	Max				
Forward Voltage	VF	If=200mA	-	USL ¹ ×1.1				
Reverse Current	IR	VR =5V	-	100μΑ				
Luminous Intensity	lv	If=200mA	LSL ² ×0.7	-				

Notes:

1. USL: Upper specification level

2. LSL: Lower specification level



Revision History

Changes since last revision	Page	Version No.	Revision Date
Initial Release		1.0	02-03-2019
Update the Drawing and Parameter	1,2,3,4	1.1	05-13-2019
Update the Drawing	1	1.2	03-05-2021

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- 2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.